

AUTOMOTIVE GRADE

AUIRFZ24NS **AUIRFZ24NL**

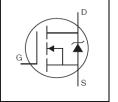
Features

- Advanced Planar Technology
- Low On-Resistance
- Dynamic dV/dT and dI/dT capability
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Timax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

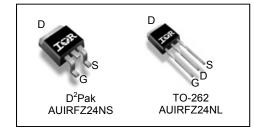
Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications





V _{DSS}	55V
R _{DS(on)} max.	0.07Ω
I _D	17A



G	D	S
Gate	Drain	Source

Page part number Dackage Type		Standard Pack		Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRFZ24NL	TO-262	Tube	50	AUIRFZ24NL
ALUDEZOANO	D²-Pak	Tube	50	AUIRFZ24NS
AUIRFZ24NS	D -Pak	Tape and Reel Left	800	AUIRFZ24NSTRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	17	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	12	Α
DM	Pulsed Drain Current ①	68	
P _D @T _A = 25°C	Maximum Power Dissipation	3.8	10/
P _D @T _C = 25°C	Maximum Power Dissipation	45	W
	Linear Derating Factor	0.3	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
= AS	Single Pulse Avalanche Energy (Thermally Limited) ②	71	mJ
AR	Avalanche Current ①	10	A
= AR	Repetitive Avalanche Energy ①	4.5	mJ
dv/dt	Peak Diode Recovery ③	6.8	V/ns
Γ _J	Operating Junction and	-55 to + 175	
T_{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case		3.3	°CAM
$R_{ heta JA}$	Junction-to-Ambient (PCB Mount), D ² Pak®		40	°C/W

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^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.052		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.07	Ω	V _{GS} = 10V, I _D = 10A ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Trans conductance	4.5			S	V _{DS} = 25V, I _D = 10A
	Projecto Course Lookens Current			25		$V_{DS} = 55V, V_{GS} = 0V$
I _{DSS}	rain-to-Source Leakage Current			250	μA	$V_{DS} = 44V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	A	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

-		-	-		
Q_g	Total Gate Charge	 	20		I _D = 10A
Q_{gs}	Gate-to-Source Charge	 	5.3	nC	V _{DS} = 44V
Q_{gd}	Gate-to-Drain Charge	 	7.6		V _{GS} = 10V, See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	 4.9			$V_{DD} = 28V$
t _r	Rise Time	 34		no	I _D = 10A
$t_{d(off)}$	Turn-Off Delay Time	 19		ns	$R_G = 24\Omega$
t _f	Fall Time	 27			$R_D = 2.6\Omega$, See Fig. 104
Ls	Internal Source Inductance	 7.5			Between lead, and center of die contact
C_{iss}	Input Capacitance	 370			$V_{GS} = 0V$
C_{oss}	Output Capacitance	 140		рF	V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance	65			f = 1.0MHz, See Fig. 5

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions	
I _S	Continuous Source Current (Body Diode)			17		MOSFET symbol showing the	
I _{SM}	Pulsed Source Current (Body Diode) ①			68		integral reverse p-n junction diode.	
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 10A, V_{GS} = 0V $ ④	
t _{rr}	Reverse Recovery Time		56	83	ns	$T_J = 25^{\circ}C$, $I_F = 10A$	
Q_{rr}	Reverse Recovery Charge		120	180	nC	di/dt = 100A/µs ④	
t _{on}	Forward Turn-On Time	Intrinsic	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)				

Notes:

- ② Limited by T_{Jmax} , starting $T_J = 25$ °C, L = 1.0mH, $R_G = 25\Omega$, $I_{AS} = 10$ A, $V_{GS} = 10$ V. (See fig.12)
- $\exists \quad I_{SD} \leq 10 A, \ di/dt \leq 280 A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- 4 Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994



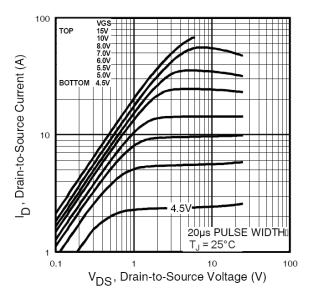


Fig. 1 Typical Output Characteristics

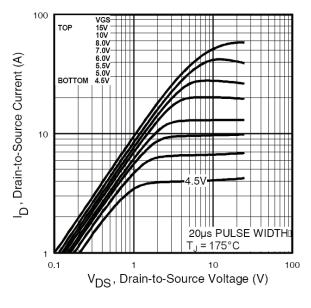


Fig. 2 Typical Output Characteristics

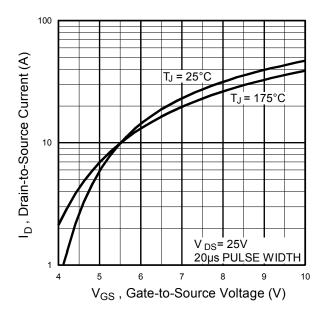


Fig. 3 Typical Transfer Characteristics

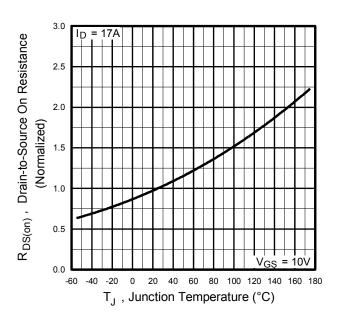


Fig. 4 Normalized On-Resistance vs. Temperature



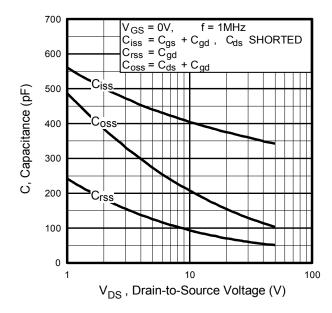


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

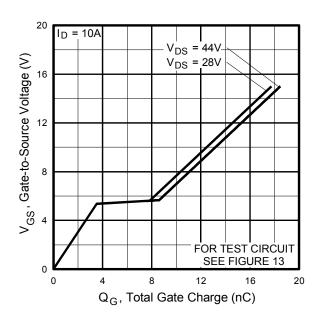


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

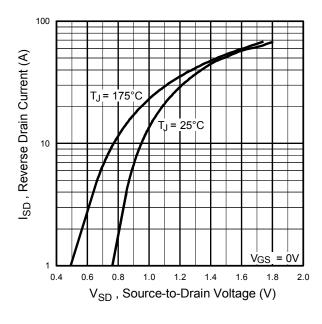


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

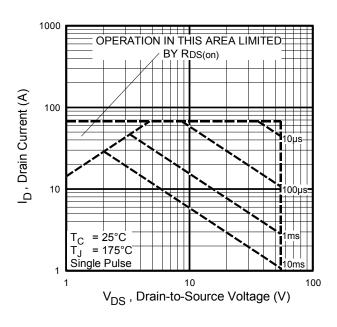


Fig 8. Maximum Safe Operating Area



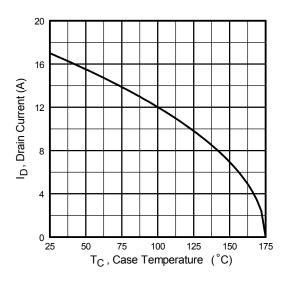


Fig 9. Maximum Drain Current vs. Case Temperature

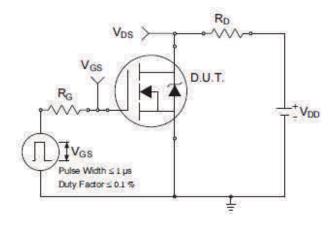


Fig 10a. Switching Time Test Circuit

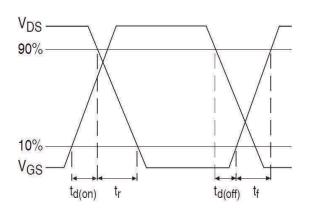


Fig 10b. Switching Time Waveforms

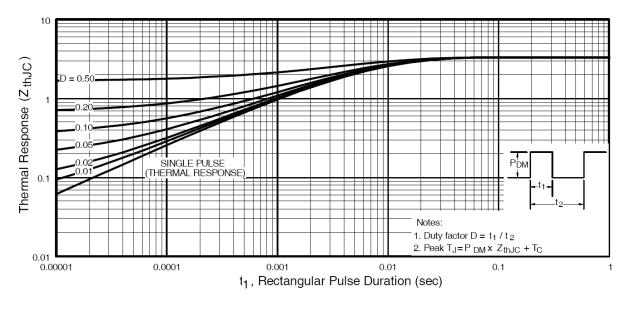


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



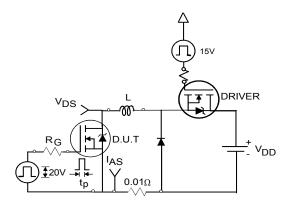


Fig 12a. Unclamped Inductive Test Circuit

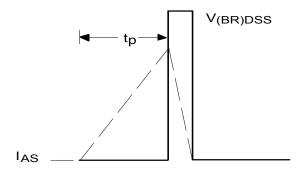


Fig 12b. Unclamped Inductive Waveforms

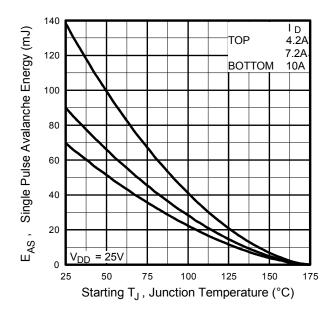


Fig 12c. Maximum Avalanche Energy vs. Drain Current

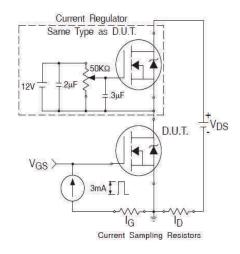


Fig 13a. Gate Charge Test Circuit

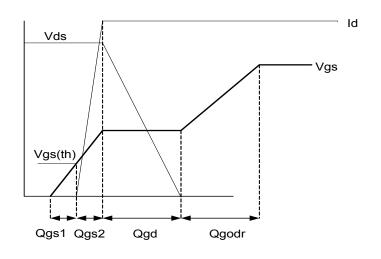


Fig 13b. Gate Charge Waveform



Peak Diode Recovery dv/dt Test Circuit

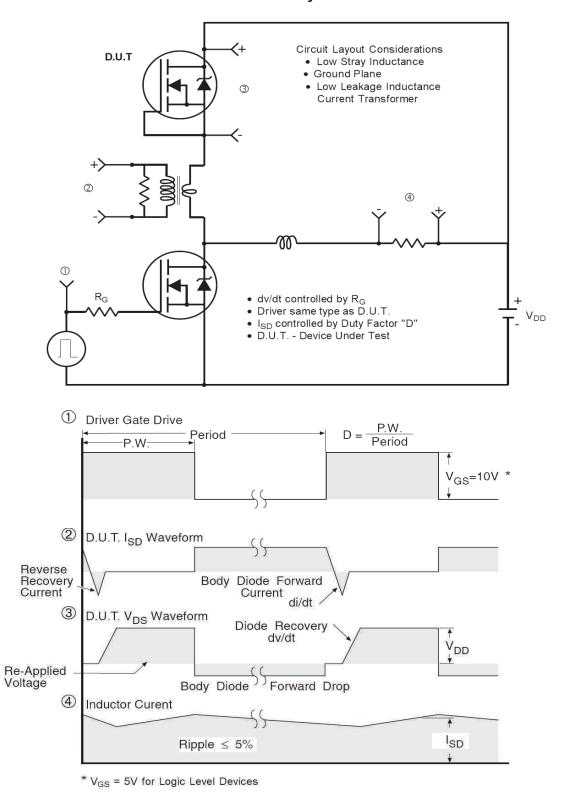
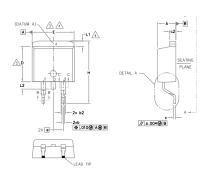
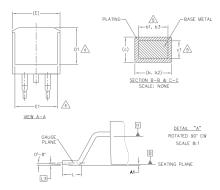


Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs



D²Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S	DIMENSIONS				
M B	MILLIM	ETERS	INC	HES	O T E S
O L	MIN.	MAX.	MIN.	MAX.	E S
А	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
Ь	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
ь3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	_	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245	_	4
е	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	_	1.68	_	.066	4
L2	_	1.78	_	.070	
L3	0.25	BSC	.010	BSC	

LEAD ASSIGNMENTS

DIODES

1.— ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.— CATHODE 3.— ANODE

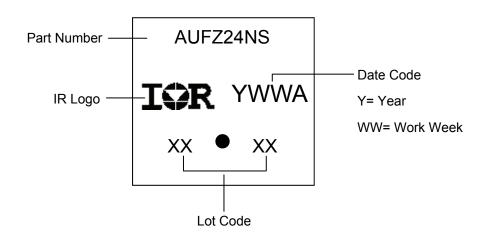
HEXFET

IGBTs, CoPACK

1.- GATE 2, 4.- DRAIN 3.- SOURCE

1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

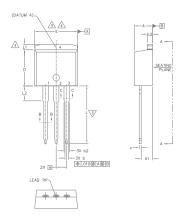
D²Pak (TO-263AB) Part Marking Information

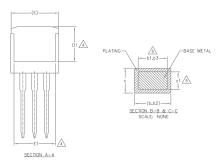


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



TO-262 Package Outline (Dimensions are shown in millimeters (inches)





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

LEAD ASSIGNMENTS

IGBTs, CoPACK

- 1.- GATE
 2.- COLLECTOR
 3.- EMITTER
 4.- COLLECTOR

HEXFET DIODES

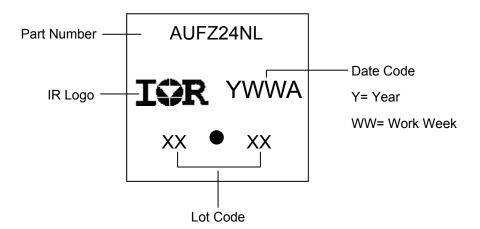
1.- ANODE (TWO DIE) / OPEN (ONE DIE) 1.- GATE

2.- DRAIN 3.- SOURCE 2, 4.- CATHODE 3.- ANODE

4.- DRAIN

S Y M		N			
В	MILLIM	ETERS	INC	O T E S	
0 L	MIN.	MAX.	MIN.	MAX.	S
А	4.06	4.83	.160	.190	
A1	2.03	3.02	.080	.119	
b	0.51	0.99	.020	.039	
b1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
ь3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	_	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245		4
е	2.54	BSC	.100 BSC		
L	13.46	14.10	.530	.555	
L1	_	1.65	_	.065	4
L2	3.56	3.71	.140	.146	

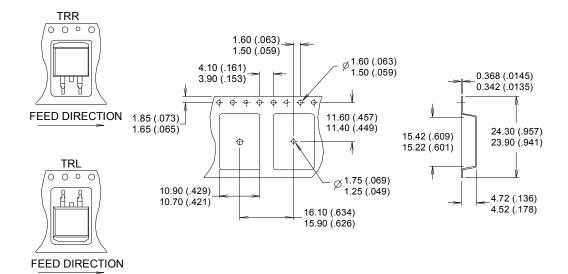
TO-262 Part Marking Information

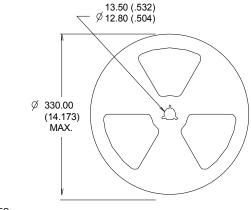


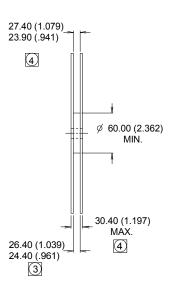
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



D²Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







NOTES:

- 1. COMFORMS TO EIA-418.
- CONTROLLING DIMENSION: MILLIMETER.
- 🗷 DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

	T				
Qualification Level		Automotive (per AEC-Q101)			
		Comments: This part number(s) passed Automotive qualification. Infineon's			
		onsumer qualification level is granted by extension of the higher			
	Automotive leve	l			
Moisture Sensitivity Level		MSL1			
		111021			
Machino Model		Class M2 (+/- 150V) [†]			
iviacilile iviodei	AEC-Q101-002				
Lluman Dady Madal	Class H1A (+/- 500V) [†]				
Human Body Model	AEC-Q101-001				
Channed Daviss Madel	Class C5 (+/- 2000V) [†]				
Charged Device Model		AEC-Q101-005			
HS Compliant Yes					
	Machine Model Human Body Model Charged Device Model	Industrial and Control Automotive level Sensitivity Level Machine Model Human Body Model Charged Device Model			

[†] Highest passing voltage.

Revision History

Date	Comments
10/27/2015	Updated datasheet with corporate template
	Corrected ordering table on page 1.

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